

Form PTO-1449 U.S. Department of Chamerce (REV. 2-82) Patent and Trademark Office

## INFORMATION DISCLOSURE STATEMENT BY APPLICANT

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Atty. Docket No. 070050.1520 (A32095 PCT-USA)	Serial No. 09/830,899					
Applicant Paek, Seungyup et al.						
Filing Date May 2, 2001	Group To Be Assigned 2/7/					

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Technology Center 2100
Filing Date if **U.S. PATENT DOCUMENTS** Document No. Date Name Class \*Exam. Init. 03/18/97 Cruz et al. Eld 04/22/97 Palmer et al. Braden-Harder et al. 05/13/97 Elek Elek Elek 06/24/97 de Carmo et al. 12/09/64 Cox et al. 12/23/97 Johnson et al. 500. 01/27/98 Kondo et al. 103R 05/26/98 Wu et al. Ō 09/08/98 Laursen et al. 11/13/98 Chen et al. 

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<sup>\*</sup> Examiner: Initial citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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